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FQ8J/4 1449 (S&J Version)

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BY APPLICANT

	Sheet 1 of 1			
Docket No.: 28951.2125				
Applicant: A. IGUCHI et al.				
Application No.: 10/519,361				
Filing Date: 12/28/2004				
Examiner:	Group Art Unit: 2821			

Examiner's	Document No.	Date	PATENT DOCUMENT Inventor	Class	Subclass	Filin	g Date
Initials*	Document 140.	MM/YYYY		J 55			ropriate
MA	2002/180651 A1	12/2002	Hareyama	343	702		
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Examiner's	Document No.	Date	Country	Class	Subclass	Translation	
Initials*		MM/YYYY				Yes	No
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Examiner's	10 10	1	Date Considered	12/11/25
Signature	Chan Wien	H		12/11/03

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1.	ľ	\$		DT09 Reold	PCT/PTO 2	8 DEC 2004
FORM PTO 1449 (modified)			ATTY DOCKET NO. MEIC:185	SE-	NOT 0/5	19361
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)		APPLICANT Akihiko IGUCHI et al.				
(Use several sheets if necessary)			FILING DATE December 28, 2004	GROUP 282		
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